Issue Classification

Application/Control No.	Applicant(s)/Patent Under Reexamination
10817637	IWATSU, TAKESHI
Examiner	**Art Unit**
Ho, Binh V	2163

ORIGINAL		INTERNATIONAL CLASSIFICATION												
CLASS	SUBCLASS	CLAIMED					NON-CLAIMED							
707	103 R	G	0	6	F	17 / 00 (2006.01.01)								

CROSS REFERENCE(S)					
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
707	205	204			

Ho, Binh V	07/24/2007		Total Claims Allowed:	
(Assistant Examiner)	(Date)		8	
(Legal Instruments Examiner)	7-30-07 (Date)	(Primary Examiner) DON WONG SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100 (Date) 7/26/07	O.G. Print Claim(s) 1	O.G. Print Figure 1